

FEATURES

- 10 μ s Short Circuit Withstand
- High Thermal Cycling Capability
- High Current Density Enhanced DMOS SPT
- Isolated AISiC Base With AlN Substrates
- Lead Free Construction

APPLICATIONS

- High Reliability Inverters
- Motor Controllers
- Traction Drives
- Choppers

The Powerline range of high power modules includes half bridge, chopper, dual, single and bi-directional switch configurations covering voltages from 1200V to 6500V and currents up to 2400A.

The DIM800ACM45-TS000 is a 4500V, soft punch through n-channel enhancement mode, insulated gate bipolar transistor (IGBT) chopper module. The IGBT has a wide reverse bias safe operating area (RBSOA) plus 10 μ s short circuit withstand. This device is optimised for traction drives and other applications requiring high thermal cycling capability.

The module incorporates an electrically isolated base plate and low inductance construction enabling circuit designers to optimise circuit layouts and utilise grounded heat sinks for safety.

ORDERING INFORMATION

Order As:

DIM800ACM45-TS000

Note: When ordering, please use the complete part number

KEY PARAMETERS

V_{CES}	4500V
$V_{CE(sat)}$ * (typ)	2.7V
I_C (max)	800A
$I_{C(PK)}$ (max)	1600A

* Measured at the auxiliary terminals

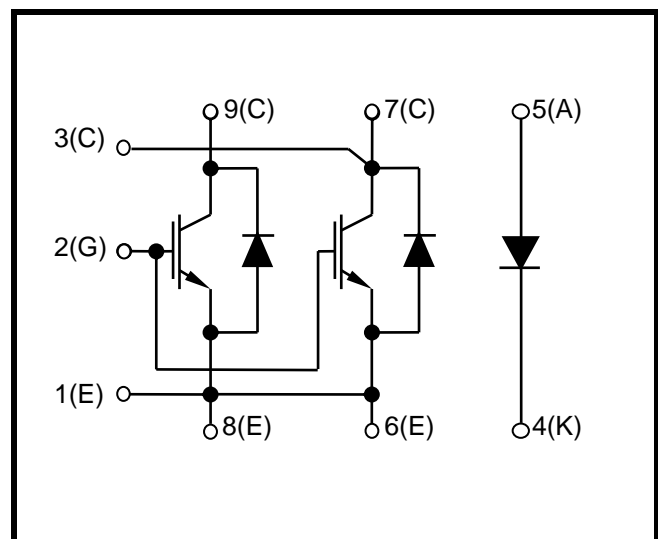


Fig. 1 Circuit configuration



Outline type code: A

(See Fig. 11 for further information)

Fig. 2 Package

ABSOLUTE MAXIMUM RATINGS

Stresses above those listed under ‘Absolute Maximum Ratings’ may cause permanent damage to the device. In extreme conditions, as with all semiconductors, this may include potentially hazardous rupture of the package. Appropriate safety precautions should always be followed. Exposure to Absolute Maximum Ratings may affect device reliability.

T_{case} = 25°C unless stated otherwise

Symbol	Parameter	Test Conditions	Max.	Units
V _{CES}	Collector-emitter voltage	V _{GE} = 0V	4500	V
V _{GES}	Gate-emitter voltage		±20	V
I _C	Continuous collector current	T _{case} = 90°C	800	A
I _{C(PK)}	Peak collector current	1ms, T _{case} = 115°C	1600	A
P _{max}	Max. transistor power dissipation	T _{case} = 25°C, T _j = 125°C	8.3	kW
I ² t	Diode I ² t value	V _R = 0, t _p = 10ms, T _j = 125°C	205	kA ² s
V _{isol}	Isolation voltage – per module	Commoned terminals to base plate. AC RMS, 1 min, 50Hz	7.4	kV
Q _{PD}	Partial discharge – per module	IEC1287, V ₁ = 4800V, V ₂ = 3500V, 50Hz RMS	10	pC

THERMAL AND MECHANICAL RATINGS

Internal insulation material: AIN
 Baseplate material: AISiC
 Creepage distance: 56mm
 Clearance: 26mm
 CTI (Comparative Tracking Index): >600

Symbol	Parameter	Test Conditions	Min	Typ.	Max	Units
R _{th(j-c)}	Thermal resistance – transistor	Continuous dissipation - junction to case	-	-	12	°C/kW
R _{th(j-c)}	Thermal resistance – diode (IGBT arm)	Continuous dissipation - junction to case	-	-	24	°C/kW
	Thermal resistance – diode (Diode arm)		-	-	24	°C/kW
R _{th(c-h)}	Thermal resistance – case to heatsink (per module)	Mounting torque 5Nm (with mounting grease)	-	-	6	°C/kW
T _j	Junction temperature	Transistor	-	-	125	°C
		Diode	-	-	125	°C
T _{stg}	Storage temperature range	-	-40	-	125	°C
	Screw torque	Mounting – M6	-	-	5	Nm
		Electrical connections – M4	-	-	2	Nm
		Electrical connections – M8	-	-	10	Nm

ELECTRICAL CHARACTERISTICS
T_{case} = 25°C unless stated otherwise.

Symbol	Parameter	Test Conditions	Min	Typ	Max	Units
I _{CES}	Collector cut-off current	V _{GE} = 0V, V _{CE} = V _{CES}			1	mA
		V _{GE} = 0V, V _{CE} = V _{CES} , T _{case} = 125°C			40	mA
I _{GES}	Gate leakage current	V _{GE} = ± 20V, V _{CE} = 0V			1	μA
V _{GE(TH)}	Gate threshold voltage	I _C = 80mA, V _{GE} = V _{CE}		5.8		V
V _{CE(sat)}	Collector-emitter saturation voltage	V _{GE} = 15V, I _C = 800A		2.7		V
		V _{GE} = 15V, I _C = 800A, T _j = 125°C		3.5		V
I _F	Diode forward current	DC		800		A
I _{FM}	Diode maximum forward current	t _p = 1ms		1600		A
V _F	Diode forward voltage	I _F = 800A		2.8		V
		I _F = 800A, T _j = 125°C		3.2		V
C _{ies}	Input capacitance	V _{CE} = 25V, V _{GE} = 0V, f = 1MHz		100		nF
Q _g	Gate charge	±15V		15		μC
C _{res}	Reverse transfer capacitance	V _{CE} = 25V, V _{GE} = 0V, f = 1MHz		TBC		nF
L _M	Module inductance			15		nH
R _{INT}	Internal transistor resistance			TBC		μΩ
SC _{Data}	Short circuit current, I _{SC}	T _j = 125°C, V _{CC} = 3400V t _p ≤ 10μs, V _{GE} ≤ 15V V _{CE(max)} = V _{CES} - L* x dl/dt IEC 60747-9		2400		A

Note:
^{*} L is the circuit inductance + L_M

ELECTRICAL CHARACTERISTICS

$T_{case} = 25^{\circ}C$ unless stated otherwise

Symbol	Parameter	Test Conditions	Min	Typ.	Max	Units
$t_{d(off)}$	Turn-off delay time	$I_C = 800A$ $V_{GE} = \pm 15V$ $V_{CE} = 2800V$ $R_{G(ON)} = 3.9\Omega$ $R_{G(OFF)} = 3.9\Omega$ $C_{ge} = 150nF$ $L_S \sim 165nH$		3000		ns
t_f	Fall time			600		ns
E_{OFF}	Turn-off energy loss			3000		mJ
$t_{d(on)}$	Turn-on delay time			900		ns
t_r	Rise time			350		ns
E_{ON}	Turn-on energy loss			3200		mJ
Q_{rr}	Diode reverse recovery charge	$I_F = 800A$ $V_{CE} = 2800V$ $dI_F/dt = 1900A/\mu s$		880		μC
I_{rr}	Diode reverse recovery current			680		A
E_{rec}	Diode reverse recovery energy			1480		mJ

$T_{case} = 125^{\circ}C$ unless stated otherwise

Symbol	Parameter	Test Conditions	Min	Typ.	Max	Units
$t_{d(off)}$	Turn-off delay time	$I_C = 800A$ $V_{GE} = \pm 15V$ $V_{CE} = 2800V$ $R_{G(ON)} = 3.9\Omega$ $R_{G(OFF)} = 3.9\Omega$ $C_{ge} = 150nF$ $L_S \sim 165nH$		3100		ns
t_f	Fall time			560		ns
E_{OFF}	Turn-off energy loss			3100		mJ
$t_{d(on)}$	Turn-on delay time			900		ns
t_r	Rise time			360		ns
E_{ON}	Turn-on energy loss			4300		mJ
Q_{rr}	Diode reverse recovery charge	$I_F = 800A$ $V_{CE} = 2800V$ $dI_F/dt = 2000A/\mu s$		1450		μC
I_{rr}	Diode reverse recovery current			750		A
E_{rec}	Diode reverse recovery energy			2500		mJ

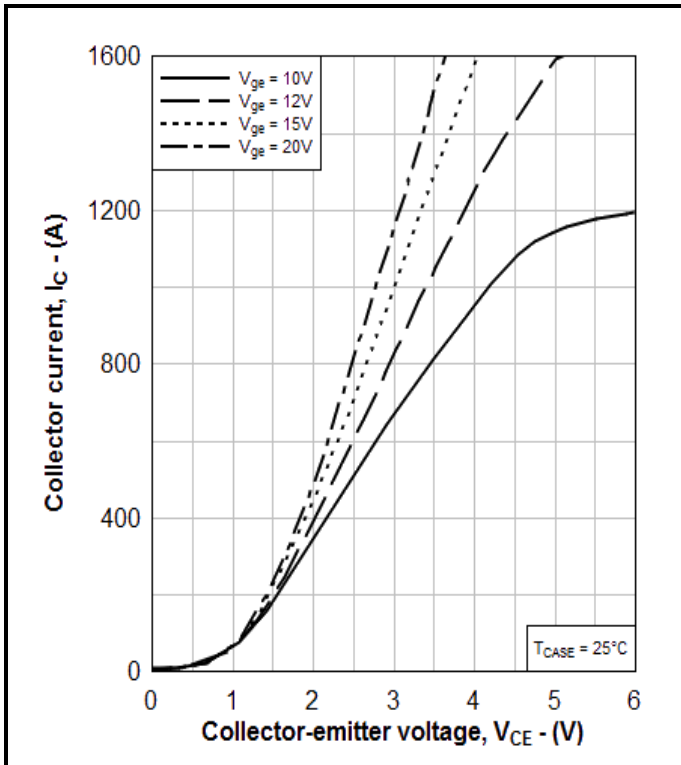


Fig. 3 Typical output characteristics

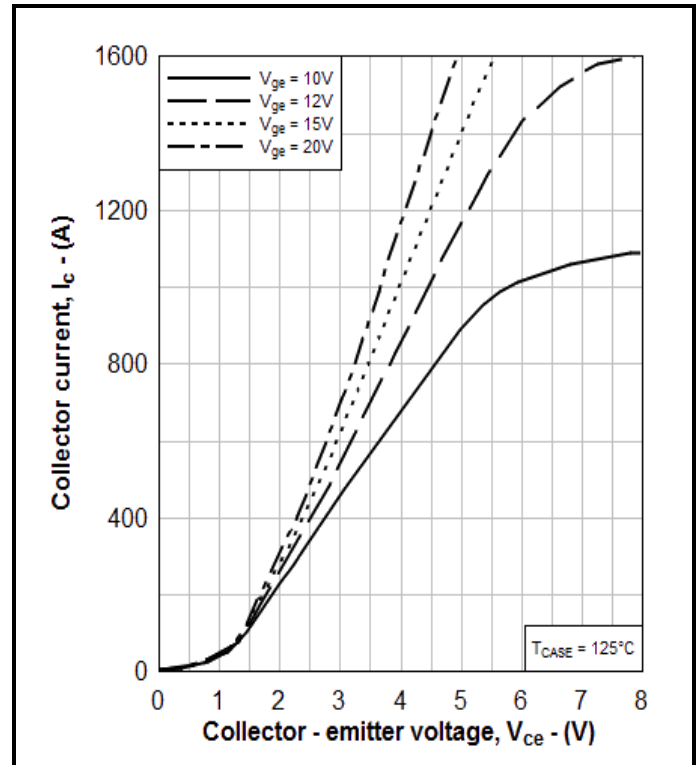


Fig. 4 Typical output characteristics

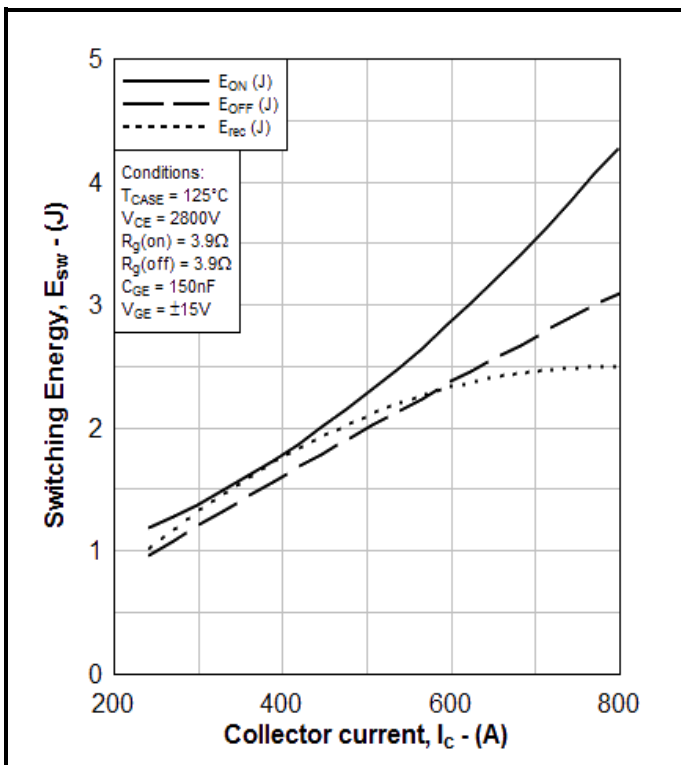


Fig. 5 Typical switching energy vs collector current

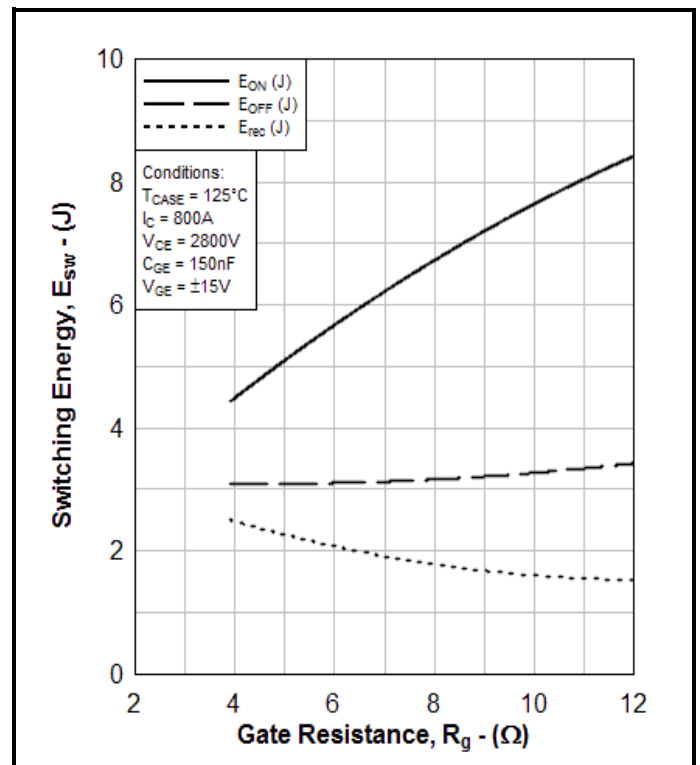


Fig. 6 Typical switching energy vs gate resistance

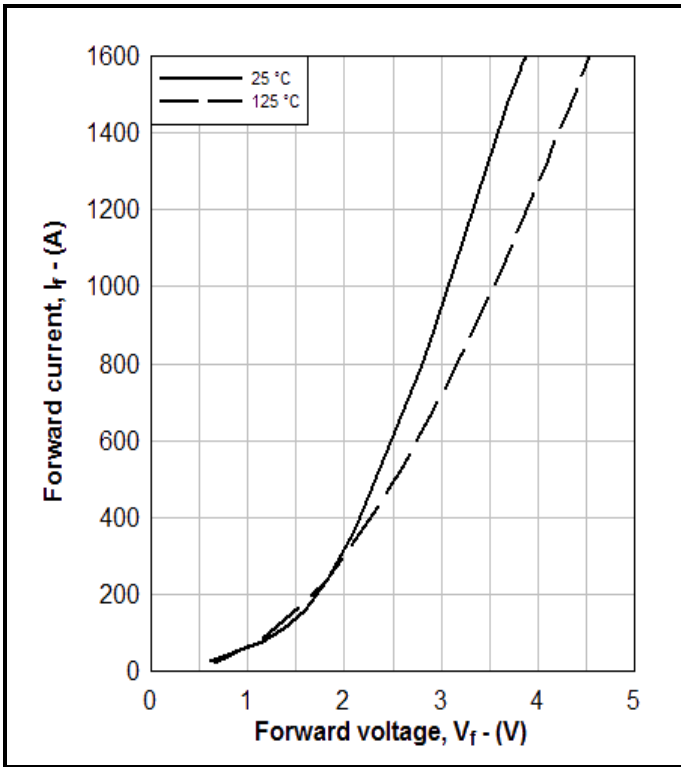


Fig. 7 Diode typical forward characteristics

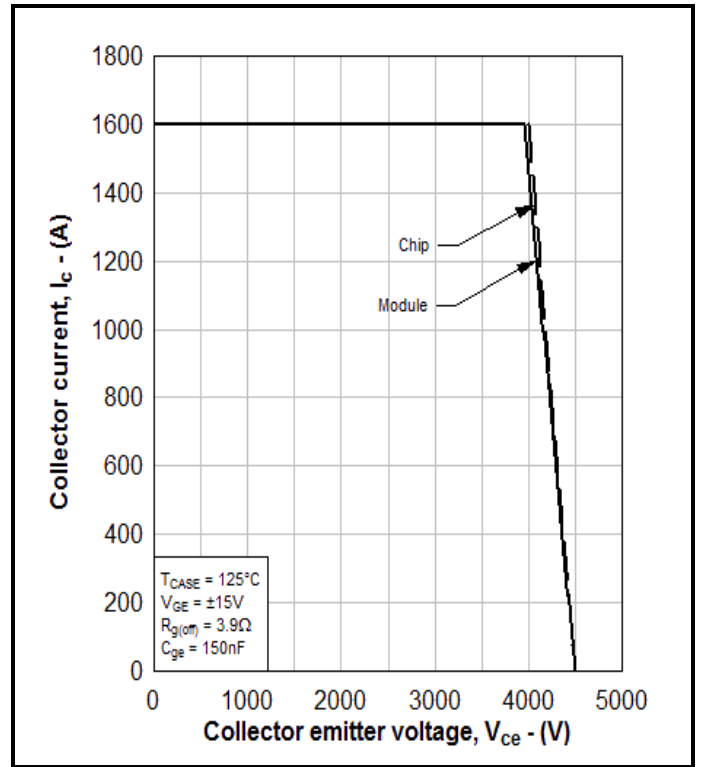


Fig. 8 Reverse bias safe operating area

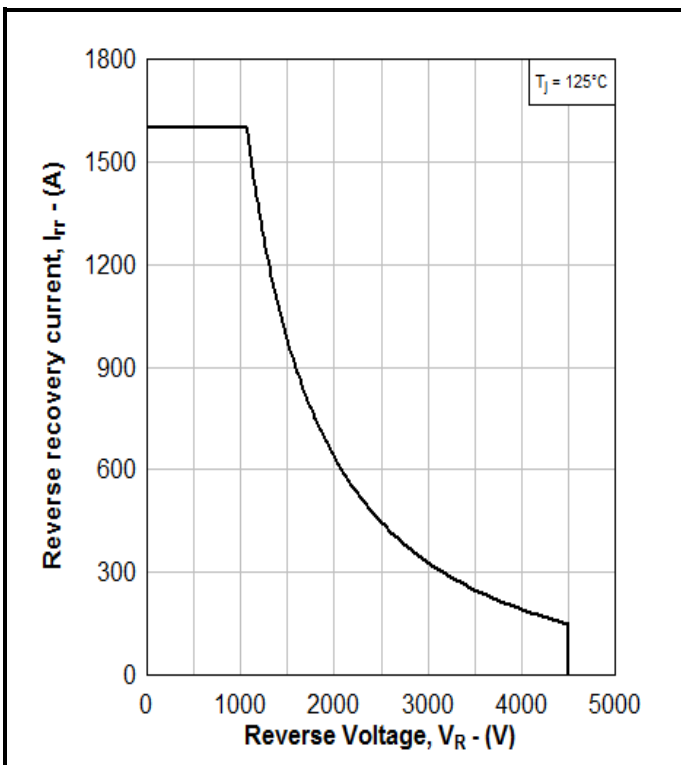


Fig. 9 Diode reverse bias safe operating area

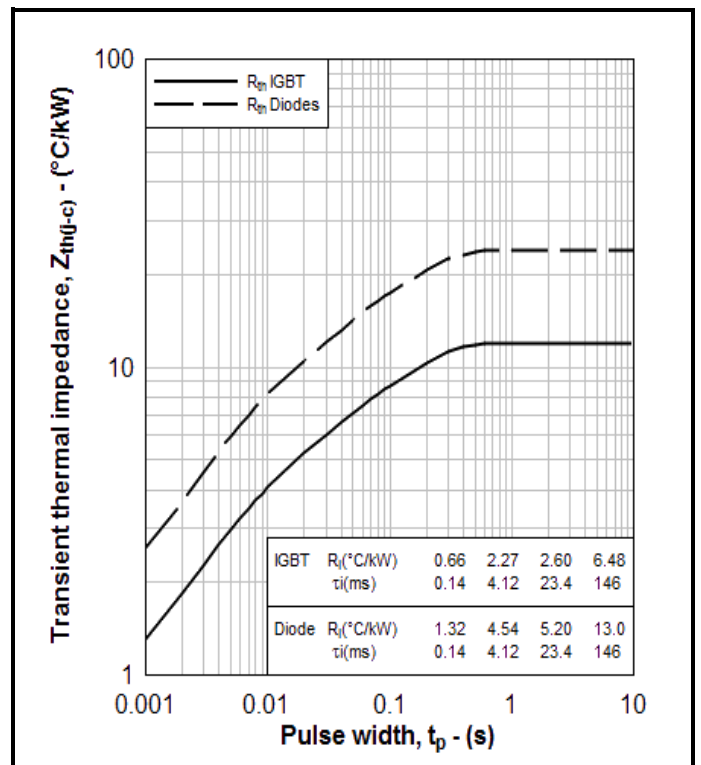
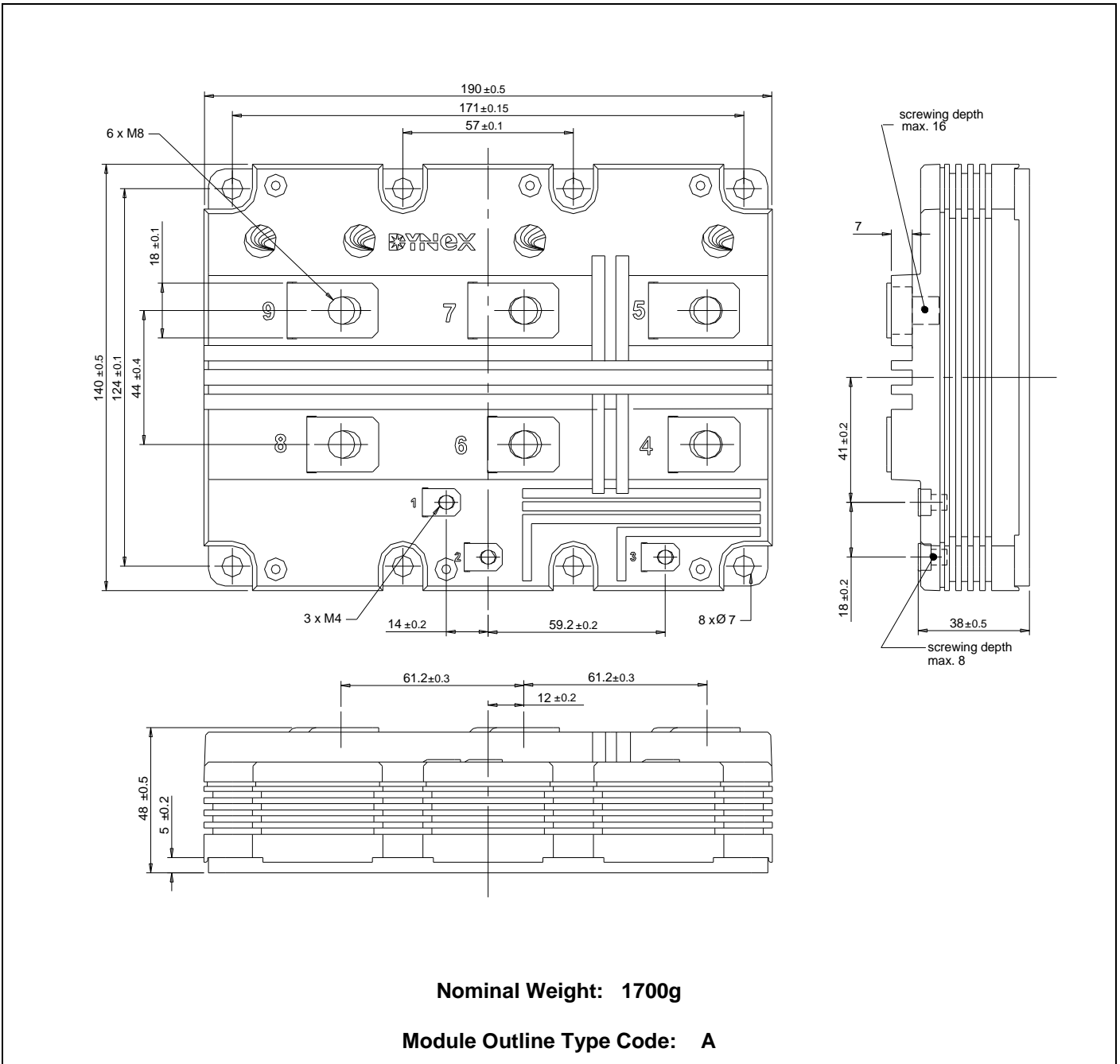


Fig. 10 Transient thermal impedance

PACKAGE DETAILS

For further package information, please visit our website or contact Customer Services.
 All dimensions in mm, unless stated otherwise.
DO NOT SCALE.


Fig. 11 Module outline drawing

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